

S1C17 Family C Compiler Package Ver.3.1.x

S5U1C17001C Release History and Issues

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1. Release History

GNU17 3.1.2: Dec. 13, 2017

	Changes	Issues	Resolved Issues
IDE	MCU definition of EmbSysRegView was updated.	IDE-009 IDE-011	
C Compiler	• None	GCC-002 GCC-003	
Library	• None	LIB-002 LIB-003	
Assember	• None		
Linker	• None		
Debugger	Failures detected by in-hose test are corrected.	GDB-004 GDB-008	GDB-009 GDB-010 GDB-011 GDB-012 GDB-013
ICD Driver	• None		
Other Tools	C17 MCU model-specific information was updated.	ETC-003	

GNU17 3.1.1: Jan. 20, 2017

	Changes	Issues	Resolved Issues
IDE	 The version of Eclipse was changed from 4.5.1 to 4.5.2. Wizard to create "GNU17 Linker Script" was defined. Linker scripts are selectable in GNU17 Setting of the project property. "c17 flv" and "c17 flvs" command are able to execute from the C17/debug command menu. GNU17 project template was updated. MCU definition of EmbSysRegView was updated. Failures detected by in-house test are corrected. 	IDE-009 IDE-011	
C Compiler	Failures detected by in-house test are corrected.	GCC-002 GCC-003	
Library	 crt0.o, libc.a, libg.a and libgcc.a were re-build. Failures detected by in-house test are corrected. 	LIB-002 LIB-003	
Assember	• None		
Linker	The method of updating debugging information was changed, when the optimization of the output code size (-relax) was specified.		GLD-002
Debugger	 ICDmini 1.0/1.1/2.0 are supported. MCU definition of ES-Sim17 (Peripheral Circuit Simulator) was updated. Convenience variable \$icdLastLapTime, \$icdLastLapUs, \$icdTotalLapTime and \$icdTotalLapUs were defined to show the lap time. It is possible to use with ICDmini environment. Failures detected by in-hose test are corrected. 	GDB-004	GDB-002 GDB-006 GDB-007
ICD Driver	• The driver for ICDmini 1.0/1.1/2.0 is included.		
Other Tools	 The ptd.exe was updated to output error messages according to the GNU17 manual. External builder tools (make and post-build batch) were bundled. C17 MCU model-specific information was updated. Sample projects were updated using new project template. 	ETC-003	ETC-002

GNU17 3.1.0: Apr. 11, 2016

	Changes	Issues	Resolved Issues
IDE	 The version of Eclipse was changed from 4.4.1 to 4.5.1. SP register initial value, flash security key and flash protect bits are prepared in GNU17 Setting of the project property. IDE menu "C17" was added. GDB command files (reset.gdb / reset_target.gdb / userdefine.gdb) are able to execute from IDE. Details of PSR are able to check in Register View. MCU definition of EmbSysRegView plug-in was updated. Failures detected by in-house test are corrected. 	IDE-009	IDE-010
C Compiler	 The version of GCC was changed from 4.9.1 to 4.9.3. Failures detected by in-house test are corrected. 	GCC-002 GCC-003	GCC-005 GCC-006
Library	 crt0.o, libc.a, libg.a and libgcc.a were re-build. Failures detected by in-house test are corrected. 	LIB-002 LIB-003	
Assember	• The version of binutils was changed from 2.24 to 2.25.1.		
Linker	• The version of binutils was changed from 2.24 to 2.25.1.		
Debugger	 ES-Sim17 (Peripheral Circuit Simulator) was added. Failures detected by in-hose test are corrected. 	GDB-002 GDB-004	GDB-005
ICD Driver	• None		
Other Tools	 New sample projects were added. C17 MCU model-specific information was updated. 	ETC-002	

GNU17 3.0.5: Oct. 30, 2015

	Changes	Issues	Resolved Issues
IDE	 Wizard to create "GNU17 Debug Configuration" was defined. Creation of PA file was changed to the last step of the post build process, because it is not able to create PA file for the program on RAM. A dummy g++ (calls xgcc) was prepared for the environment checker of IDE. It is not a C++ compiler. Making "inc" folder and setting it to the include path were added when the project was made newly. The parameter of the c17 model command of debugger command file "gdb*.ini" follows to the change of Target CPU. The parameter of the c17 model_path command of debugger command file "gdb*.ini" follows to the GNU17 installation folder. The problem of outputting ROM data different from the size specification of some MCUs was solved. EmbSysRegView plug-in was installed. Failures detected by in-house test are corrected. 	IDE-009	IDE-004 IDE-005 IDE-006
C Compiler	 The definition of "stdarg.h" was changed to pass the arguments of struct, long long, double and etc. to the function taking variable number of arguments. Failures detected by in-house test are corrected. 	GCC-002 GCC-003	GCC-004
Library	 crt0.o, libc.a and libg.a were re-build. Failures detected by in-house test are corrected. 	LIB-002 LIB-003	
Assember	• None		
Linker	 *.o files containing no program code became linkable. The issue that the linker sometimes fails in the main function linkage at O2 or more optimization level was corrected. Failures detected by in-house test are corrected. 		
Debugger	 break and tbreak commands were changed to use hardware breakpoints, if it is possible. Failures detected by in-hose test are corrected. 	GDB-002 GDB-004	
ICD Driver	The ICD driver was signed.		
Other Tools	 Installation processing was changed so that all users on installed PC might use GNU17. The method of WinMDC's checking the size of input ROM data was changed. New sample projects were added. C17 MCU model-specific information was updated. 		

GNU17 3.0.4: May. 27, 2015

	Changes	Issues	Resolved Issues
IDE	Project type to create libraries is supported.	IDE-004	IDE-001
		IDE-005	IDE-002
		IDE-006	IDE-003
			IDE-007
			IDE-008
C Compiler	Failures detected by in-house test are corrected.	GCC-002	GCC-001
		GCC-003	
		GCC-004	
Library	 crt0 is available with gcc3. libg.a was implemented again to ignore compiler 	LIB-002	LIB-001
	optimizations.	LIB-003	
	 limits.h was updated because of UINT_MAX, USHRT_MAX, LONG_MAX and SHRT_MIN definitions. 		
	 GCC4 Emulation library and ANSI library were built with GCC4. 		
Assember	Failures detected by in-house test are corrected.		GAS-001
Linker	Removing unnecessary "ext" instructions is supported.		GLD-001
Debugger	• None	GDB-002	GDB-001
		GDB-004	
ICD Driver	• None		DRV-001
Other Tools	• None		ETC-001

GNU17 3.0.3 (GNU17 3.0 Beta2): Apl. 27, 2015

	Changes	Issues	Resolved Issues
IDE	Failures detected by in-house test are corrected.	IDE-001	IDE-002
		IDE-004	IDE-003
		IDE-005	
		IDE-006	
		IDE-007	
		IDE-008	
C Compiler	Failures detected by in-house test are corrected.	GCC-001	
		GCC-002	
Library	Symbol names defined by libg.a are changed to WRITE_FLASH and WRITE_BUF.	LIB-001	
	Entries for gcc4 are appended to libgcc.a.	LIB-002	
Assember	• None	GAS-001	
Linker	Default linker script is updated.	GLD-001	
Debugger	Failures detected by in-house test are corrected	GDB-001	
		GDB-002	
		GDB-004	
ICD Driver	• None	DRV-001	
Other Tools	• None	ETC-001	

GNU17 3.0.2 (GNU17 3.0 Beta): Apl. 03, 2015

	Changes	Issues	Resolved Issues
IDE	 Generating new GNU17 V3 project is available. Importing GNU17 V2 project is available. Setting GNU17 project properties is available. 	IDE-001 IDE-002 IDE-003	
C Compiler	 Failures detected by in-house test are corrected Generating delayed branch instructions are supported. 	GCC-001	
Library	The following libraries were re-compiled.libg.a	LIB-001	
Assember	• None	GAS-001	
Linker	Default linker script is updated.	GLD-001	
Debugger	Failures detected by in-house test are corrected	GDB-001 GDB-002 GDB-004	
ICD Driver	• None	DRV-001	
Other Tools	 The following tools were added. moto2ff.exe sconv32.exe 	ETC-001	

GNU17 3.0.1 (GNU17 3.0 Alpha2): Feb. 28, 2015

	Changes	Issues	Resolved Issues
IDE	• None	IDE-001	
C Compiler	Failures detected by in-house test are corrected	GCC-001	
Library	 The following libraries were re-compiled. crt0.o libg.a 	LIB-001	
Assember	• None	GAS-001	
Linker	• None	GLD-001	
Debugger	Debugging the target system using the ICDmini3 is available.	GDB-001 GDB-002	GDB-003
ICD Driver	• None	DRV-001	
Other Tools	• None	ETC-001	

GNU17 3.0.0 (GNU17 3.0 Alpha): Jan. 30, 2015

	Changes	Issues
IDE	 The version of Eclipse was changed from 3.4.0 to 4.4.1. The plug-in for GNU17 2.x was deleted. 	IDE-001
C Compiler	 The version of GCC was changed from 3.3.2 to 4.9.1. The following command line options were deleted. -mshort-offset -mno-sjis-filt 	GCC-001
Library	 The following libraries were added. crt0.o libg.a 	LIB-001
Assember	 The version of binutils was changed from 2.10.1 to 2.24. The following command line options were deleted. -mc17_ext 	GAS-001
Linker	 The version of binutils was changed from 2.10.1 to 2.24. The following command line options were deleted. -c17-overlap-noerr -c17-memoryover-noerr 	GLD-001
Debugger	 The version of gdb was changed from 5.1.1 to 7.8. The following command line options were added. model model_path The following command line options were deleted. c17-cmw c17-double_starting 	GDB-001 GDB-002
	 Commands correspoinding to new comand line options were added. Icdmini3 was added to Type of the target command for the ICDmini3 support. Some GNU17 original commands were deleted. 	
ICD Driver	ICDmini3 was supported.	DRV-001
Other Tools	 The version of binutils was changed from 2.10.1 to 2.24. The following tools were deleted. make.exe ccap.exe moto2ff.exe sconv32.exe LCDUtil17 Insight 	ETC-001

2. Known Issues

2.1 IDE

IDE-011 Breakpoints deleted from the Breakpoints view might remain on the Editor as a marker. In this case, it is necessary to display the Markers view, and to delete the marker.

IDE-010	Project building fails when the installed path contains space characters.
IDE-009	When "GCC Version" is changed on "GNU17 Setting" page of the project property, don't see "C/C++ Bulid / Settings" page until the property dialog is closed.
IDE-008	When "Target CPU" and "Memory Model" was changed on "GNU17 Setting" page of the project property, it is necessary to build, clean and build the project again.
IDE-007	When "GCC Version" was changed on "GNU17 Setting" page of the project property, it is necessary to restart Eclipse. (Including new gcc3 project, because gcc4 is default setting.)
IDE-006	If "Debug configuration" of the project has been removed, it is necessary to set parameters of new "Debug cofiguration" manually.
IDE-005	In case of the program located on the RAM, its builder reports an error at creating the PA file.
IDE-004	The Problem window shows a message: Progrm ""g++""not found in PATH.
IDE-003	 Project should be set manually when [GCC Version] (C compiler) 3.3 is selected. Copy sample liker script "sample/sample_gcc3/elf32c17.x" to the project folder. Adjust the project's [C/C++Build] > [Settings] > [Tool Settings] properties as followings: Change [Cross Settings] > [Path] setting to "C:\text{YEPSONYGNU17V3Ygcc3"}. Add following libraries to [Cross GCC Linker] > [Libraries] > [Libraries (-l)]. c stdio gcc\text{GCC17_COPRO} Add "-T\text{Yelf32c17.x"} to [Cross GCC Linker] > [Miscellaneous] > [Other options].
IDE-002	Installation destination folder should be C:\text{YEPSON\text{YENU17V3}}.
IDE-001	The test is not completed.

2.2 C Compiler

GCC-006	Values indicating the register allocated to variables are different from what the debugger expects.
GCC-005	Bit shift operations might overwrite a register operation immediately before.
GCC-004	The compiler may output unexpected results when "struct" "long long" "double" type arguments are passed to a variable arguments function. Please confirm the function acts appropriately by the output program.

2. Known Issues

GCC-003	How to pass arguments of some types is different in GCC4 and GCC3. Please re-build the existing
	program from sources through GCC4.

GCC-002 When calling a function which has double or long long type arguments, The way to pass those arguments is different from the manual.

GCC-001 The test is not completed

2.3 Library

LIB-003 GCC4 uses the existing libraries developed for GCC3.

LIB-002 Corresponding to the compiler issue GCC-002, functions replacing arguments are included in the emulation library.

LIB-001 The test is not completed.

2.4 Assembler

GAS-001 The test is not completed.

2.5 Linker

might not follow to the optimized address.	, debugging information	GLD-002 When the optimization of the output code size (-relax) option is specified, debugging
		might not follow to the optimized address.

GLD-001 The test is not completed.

2.6 Debugger

	This phenomenon is an operation of the Eclipse CDT, so it is a restriction item.			
GDB-008	3-008 When launching the debugger, multiple same source files are opened.			
GDB-009	Suspend (forced break) may not be possible while executing STDOUT (standard output).			
GDB-010	If the debugger is started twice while the debugger is running, an error occurs.			
GDB-011	Call command does not work properly.			
GDB-012	Do not set the breakpoint to the correct address in the prologue or where there is no code.			
GDB-013	Even if five or more breakpoints are set, if the current PC value is equal to the breakpoint, no error occurs when executing Resume (program execution).			

GDB-006	Even if the peripheral circuit simulator begins execution, ES-Sim window is not displayed.
GDB-005	A finish command executed on the function that does not end might not be able to be suspended.
GDB-004	Results of commands on GDB console may not be reflected in the GUI.
GDB-003	Debuging the target system using the ICDmini3 from the IDE is not available.
GDB-003 GDB-002	

2.7 ICD driver

DRV-001 The test is not completed.

2.8 Other Tools

ETC-003	When the installer installs VC++2008, the temporary files are generated to the drive with the largest
	capacity. And, it remains. This phenomenon is trouble of VC++2008.

ETC-002	ptd.exe does not output error messages listed in the manual.
ETC-001	The test is not completed.

Revision History

Attachment-1

Rev. No.	Date	Page	Category	Contents
Rev 1.0	2015/01/30	All	new	First revision.
Rev 1.1	2015/02/28	1,3	Add	Add GNU17V3.0.1 release history.
Rev 1.2	2015/04/03	2,5,6	Add	Add GNU17V3.0.2 release history.
Rev1.3	2015/04/27	2,6	Add	Add GNU17V3.0.3 release history.
Rev1.4	2015/05/27	2,7,8	Add	Add GNU17V3.0.4 release history.
Rev1.5	2015/10/30	2,8	Add	Add GNU17V3.0.5 release history.
Rev1.6	2016/04/11	2,9,19	Add	Add GNU17V3.1.0 release history.
Rev1.7	2017/01/20	2,10,11	Add	Add GNU17V3.1.1 release history
Rev1.8	2017/12/13	2,12	Add	Add GNU17V3.1.2 release history

International Sales Operations

America

Epson America, Inc.

Headquarter:

3840 Kilroy Airport Way

Long Beach, California 90806-2452 USA

Phone: +1-562-290-4677

San Jose Office: 214 Devcon Drive San Jose, CA 95112 USA

Phone: +1-800-228-3964 or +1-408-922-0200

Europe

Epson Europe Electronics GmbH

Riesstrasse 15, 80992 Munich,

Germany

Phone: +49-89-14005-0 FAX: +49-89-14005-110

Asia

Epson (China) Co., Ltd.

4th Floor, Tower 1 of China Central Place, 81 Jianguo Road, Chaoyang

District, Beijing 100025 China

Phone: +86-10-8522-1199 FAX: +86-10-8522-1120

Shanghai Branch

Room 1701 & 1704, 17 Floor, Greenland Center II, 562 Dong An Road, Xu Hui District, Shanghai, China Phone: +86-21-5330-4888 FAX: +86-21-5423-4677

Shenzhen Branch

Room 804-805, 8 Floor, Tower 2, Ali Center, No. 3331 Keyuan South RD(Shenzhen bay), Nanshan District, Shenzhen 518054. China

Phone: +86-10-3299-0588

FAX: +86-10-3299-0560

Epson Taiwan Technology & Trading Ltd.

15F, No.100, Songren Rd, Sinyi Dist, Taipei City 110. Taiwan

Phone: +886-2-8786-6688

Epson Singapore Pte., Ltd.

1 HarbourFront Place,

#03-02 HarbourFront Tower One, Singapore 098633 FAX: +65-6271-3182 Phone: +65-6586-5500

Seiko Epson Corp. Korea Office

19F, KLI 63 Bldg, 60 Yoido-dong, Youngdeungpo-Ku, Seoul 150-763, Korea

Phone: +82-2-784-6027 FAX: +82-2-767-3677

Seiko Epson Corp. Sales & Marketing Division

Device Sales & Marketing Department

421-8, Hino, Hino-shi, Tokyo 191-8501, Japan Phone: +81-42-587-5816 FAX: +81-42-587-5116